

Notice of References Cited		Application/Control No. 10/626,206	Applicant(s)/Patent Under Reexamination TSUGIIWA, NAOMITSU	
		Examiner Christian E. Rendón	Art Unit 3714	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0133523	09-2002	Ambler et al.	707/536
*	B	US-5,618,238	04-1997	Kruse et al.	473/70
*	C	US-2003/0115593	06-2003	Alten et al.	725/28
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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